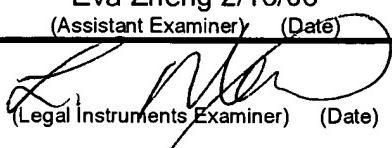


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/928,405	SHIMURA ET AL.
	Examiner	Art Unit
	Eva Yi Zheng	2634

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
375	295	375	150 142 147 349
INTERNATIONAL CLASSIFICATION		370	242 204 206 342
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			27/10
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Eva Zheng 2/16/06
(Assistant Examiner) (Date)


(Legal Instruments Examiner) (Date)

Chieh M. Fan

CHIEH M. FAN
SUPERVISORY PATENT EXAMINER
(Primary Examiner) (Date) 2/11/06

Total Claims Allowed: 15

O.G. Print Claim(s) 1	O.G. Print Fig. 1
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